## Application/Control No. Applicant(s)/Patent Under Reexamination 10/685,703 HAYAKAWA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Emmanuel M Marcelo 3654 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-5,967,920 10-1999 Dembosky et al. 474/109 \* Α k 08-1999 Stief et al. В US-5,931,754 474/109 US-5,700,214 12-1997 Kuznets et al. 474/110 С D US-US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Country Code-Number-Kind Code Name Classification MM-YYYY JP02001355691A 12-2001 Japan Ν Yamamoto 0 P Q R s Т **NON-PATENT DOCUMENTS**

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